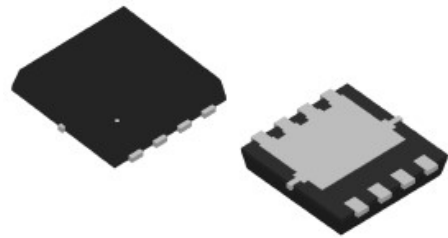


## WPM3033

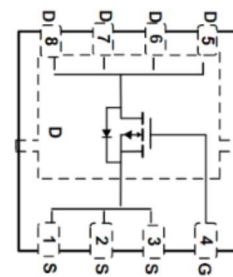
### Single P-Channel, -30V, -38A, Power MOSFET

<https://www.omnivision-group.com>

V <sub>DS</sub> (V)	Typical R <sub>DS(on)</sub> (mΩ)
-30	5.5 @ V <sub>GS</sub> =-10V
	8.5 @ V <sub>GS</sub> =-4.5V



PDFN3X3-8L



### Description

The WPM3033 is P-Channel enhancement MOS Field Effect Transistor. Uses advanced trench technology and design to provide excellent R<sub>DS(ON)</sub> with low gate charge. This device is suitable for use in DC-DC conversion, power switch and charging circuit. Standard Product WPM3033 is Pb-free.

### Pin configuration (Top view)



3033 = Device Code  
PS = Special Code  
Y = Year  
W = Week(A~z)

### Marking

### Features

- Trench Technology
- Super high density cell design
- Excellent ON resistance
- Extremely Low Threshold Voltage
- Small package PDFN3X3-8L

### Applications

- DC/DC converters
- Power supply converters circuit
- Load/Power Switching for portable device

### Order information

Device	Package	Shipping
WPM3033-8/TR	PDFN3X3-8L	3000/Tape&Reel

## Absolute Maximum ratings

Parameter	Symbol	Maximum	Unit	
Drain-Source Voltage	$V_{DS}$	-30	V	
Gate-Source Voltage	$V_{GS}$	$\pm 25$		
Continuous Drain Current <sup>d</sup>	$I_D$	$T_C=25^\circ\text{C}$	-38	A
		$T_C=100^\circ\text{C}$	-38	A
Pulsed Drain Current <sup>c</sup>	$I_{DM}$	-110	A	
Continuous Drain Current	$I_{DSM}$	$T_A=25^\circ\text{C}$	-21	A
		$T_A=70^\circ\text{C}$	-17	
Avalanche Current	$I_{AS}$	-40	A	
Avalanche Energy	$L=0.1\text{mH}, I_D=-40\text{A}, R_G=25\Omega$	$E_{AS}$	80	mJ
Power Dissipation <sup>b</sup>	$P_D$	$T_C=25^\circ\text{C}$	43.1	W
		$T_C=100^\circ\text{C}$	17.2	
Power Dissipation <sup>a</sup>	$P_{DSM}$	$T_A=25^\circ\text{C}$	4.6	W
		$T_A=70^\circ\text{C}$	3.0	
Operating Junction Temperature	$T_J$	-55 to 150	$^\circ\text{C}$	
Storage Temperature Range	$T_{STG}$	-55 to 150	$^\circ\text{C}$	

100% UIS tested in condition of  $V_D=-20\text{V}$ ,  $L=0.1\text{mH}$ ,  $V_G=-10\text{V}$ ,  $I_D=-40\text{A}$ , Rated  $V_{DS}=-30\text{V}$  P-CH.

## Thermal resistance ratings

Single Operation					
Parameter		Symbol	Typical	Maximum	Unit
Junction-to-Ambient Thermal Resistance <sup>a</sup>	$t \leq 10\text{ s}$	$R_{\theta JA}$	21	27	$^\circ\text{C/W}$
	Steady State		48	60	
Junction-to-Case Thermal Resistance	Steady State	$R_{\theta JC}$	2.3	2.9	

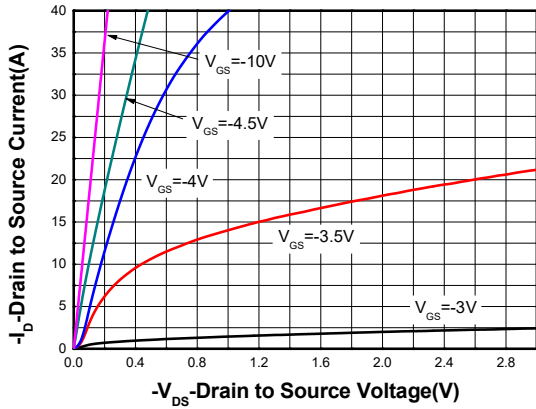
### Note:

- a The value of  $R_{\theta JA}$  is measured with the device mounted on 1-inch<sup>2</sup> (6.45cm<sup>2</sup>) with 2oz. (0.071mm thick) Copper pad on a 1.5\*1.5 inch<sup>2</sup>, 0.06-inch thick FR4 PCB, in a still air environment with  $T_A=25^\circ\text{C}$ . The power dissipation  $P_{DSM}$  is based on  $R_{\theta JA}$   $t \leq 10\text{s}$  value and the  $T_{J(MAX)}=150^\circ\text{C}$ . The value in any given application is determined by the user's specific board design.
- b The power dissipation  $P_D$  is based on  $T_{J(MAX)}=150^\circ\text{C}$ , using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heat sinking is used.
- c Repetitive rating,  $\sim 10\mu\text{s}$  pulse width, duty cycle  $\sim 1\%$ , keep initial  $T_J=25^\circ\text{C}$ , the maximum allowed junction temperature of  $150^\circ\text{C}$ .
- d The maximum current rating by source bonding technology.
- e The static characteristics are obtained using  $\sim 380\mu\text{s}$  pulses, duty cycle  $\sim 1\%$ .

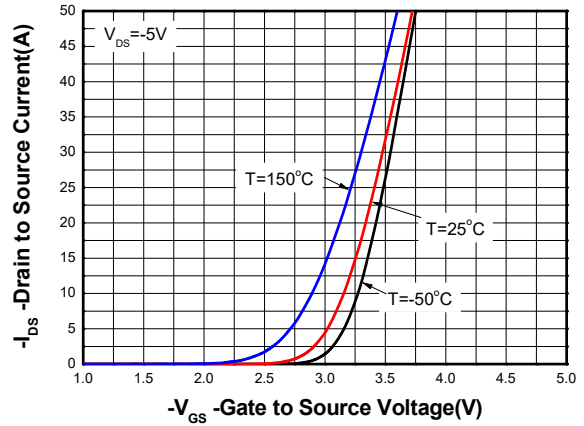
Electronics Characteristics (Ta=25°C, unless otherwise noted)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
<b>OFF CHARACTERISTICS</b>						
Drain-to-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = -250uA	-30			V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = -24V, V <sub>GS</sub> = 0V			-1	uA
Gate-to-source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = ±25V			±100	nA
<b>ON CHARACTERISTICS</b>						
Gate Threshold Voltage	V <sub>GS(TH)</sub>	V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> = -250uA	-1.0	-1.7	-2.2	V
Drain-to-source On-resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = -10V, I <sub>D</sub> = -20A		5.7	7.5	mΩ
		V <sub>GS</sub> = -4.5V, I <sub>D</sub> = -16A		8.6	12.5	
Forward Transconductance	g <sub>FS</sub>	V <sub>DS</sub> = -5V, I <sub>D</sub> = -10A		23		S
<b>CHARGES, CAPACITANCES AND GATE RESISTANCE</b>						
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1.0MHz, V <sub>DS</sub> = -15 V		2686		pF
Output Capacitance	C <sub>OSS</sub>			476		
Reverse Transfer Capacitance	C <sub>RSS</sub>			417		
Gate resistance	R <sub>g</sub>	F=1MHz		12.5		Ω
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = -10V, V <sub>DS</sub> = -15V, I <sub>D</sub> = -20 A		58.2		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>			4.8		
Gate-to-Source Charge	Q <sub>GS</sub>			11.1		
Gate-to-Drain Charge	Q <sub>GD</sub>			11.5		
<b>SWITCHING CHARACTERISTICS</b>						
Turn-On Delay Time	td <sub>(ON)</sub>	V <sub>GS</sub> = -10V, V <sub>DS</sub> = -15 V, I <sub>D</sub> = -20A, R <sub>G</sub> = 3Ω		22.5		ns
Rise Time	tr			20.5		
Turn-Off Delay Time	td <sub>(OFF)</sub>			126.5		
Fall Time	tf			67.5		
<b>BODY DIODE CHARACTERISTICS</b>						
Forward Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V, I <sub>S</sub> = -1A		-0.7	-1.2	V
Reverse Recovery Time	t <sub>rr</sub>	I <sub>F</sub> = -16A,		48		ns
Reverse Recovery Charge	Q <sub>rr</sub>	di/dt = 100A/us		28		nC

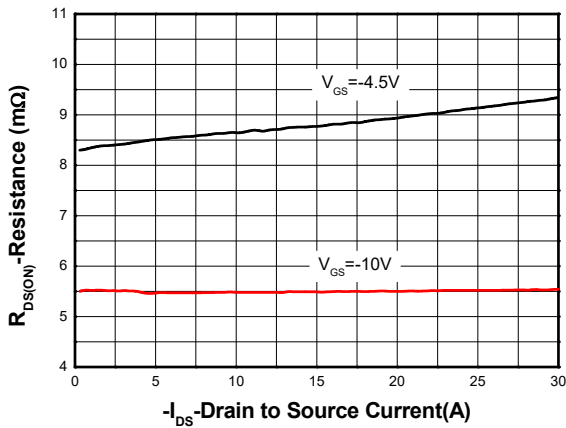
Typical Characteristics (Ta=25°C, unless otherwise noted)



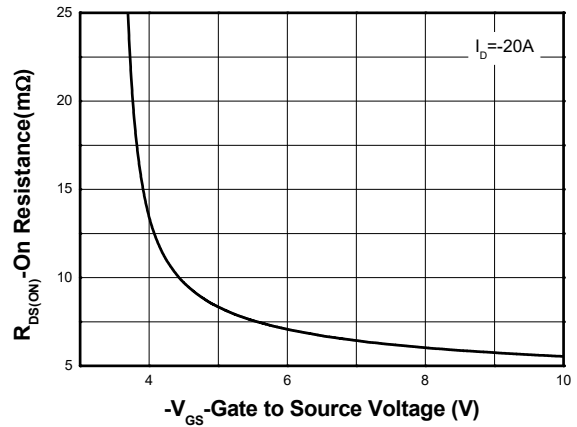
Output Characteristics <sup>e</sup>



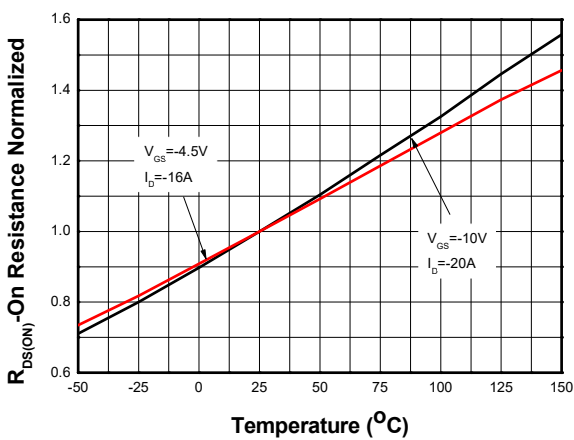
Transfer Characteristics <sup>e</sup>



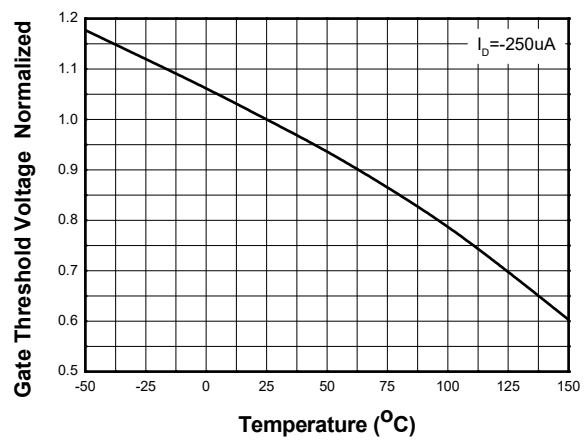
On-Resistance vs. Drain Current <sup>e</sup>



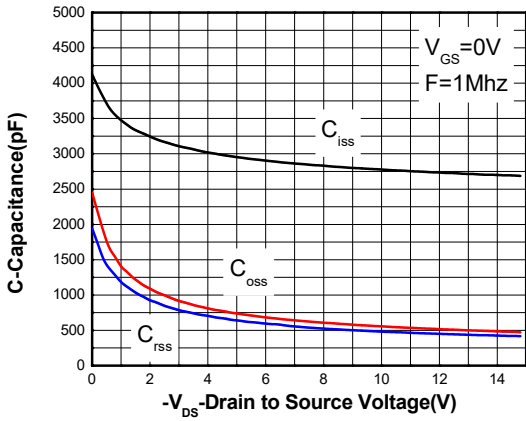
On-Resistance vs. Gate-to-Source Voltage <sup>e</sup>



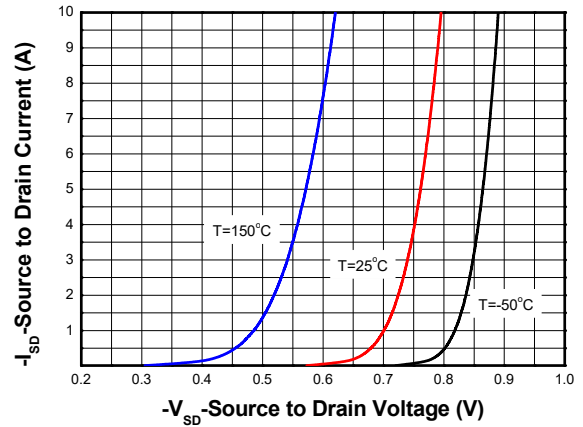
On-Resistance vs. Junction Temperature <sup>e</sup>



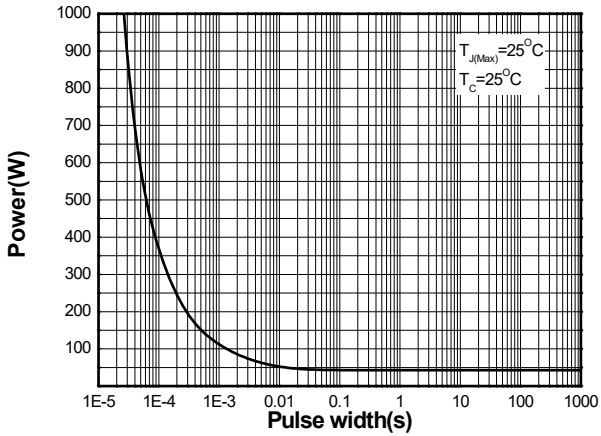
Threshold Voltage vs. Temperature



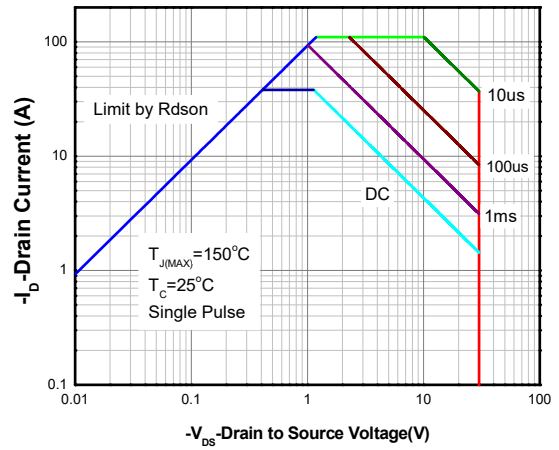
Capacitance



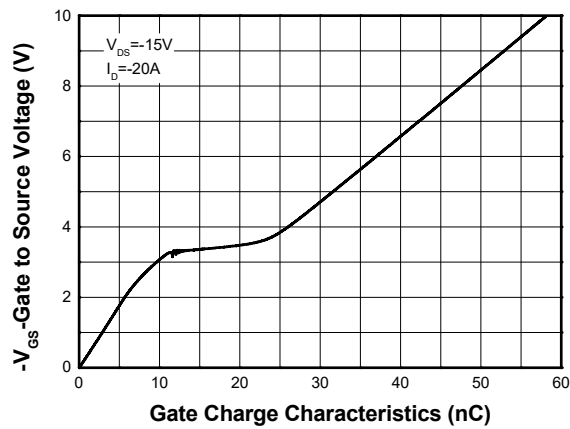
Body Diode Forward Voltage<sup>e</sup>



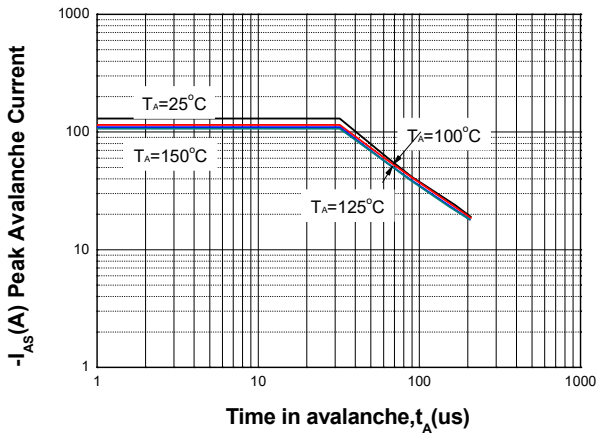
Single Pulse power



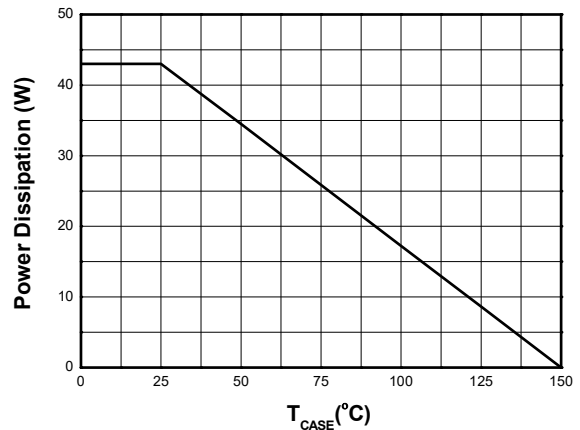
Safe Operating Power



Gate Charge Characteristics

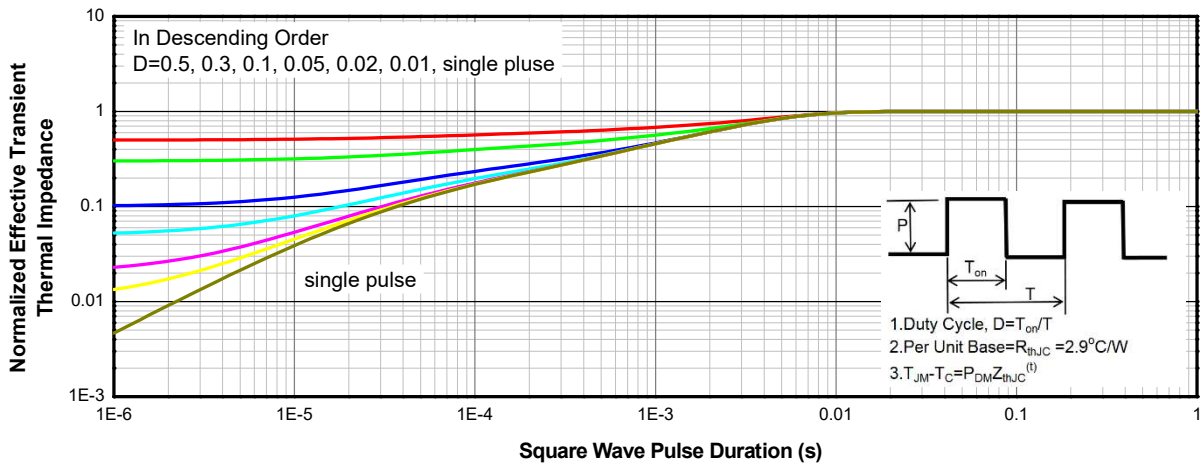


Single Pulse Avalanche capability

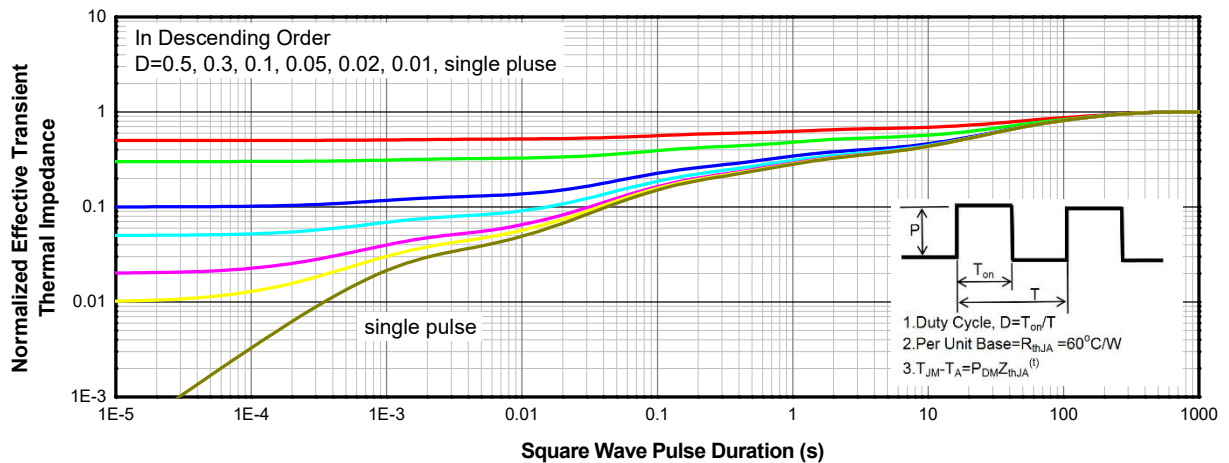


Power De-rating

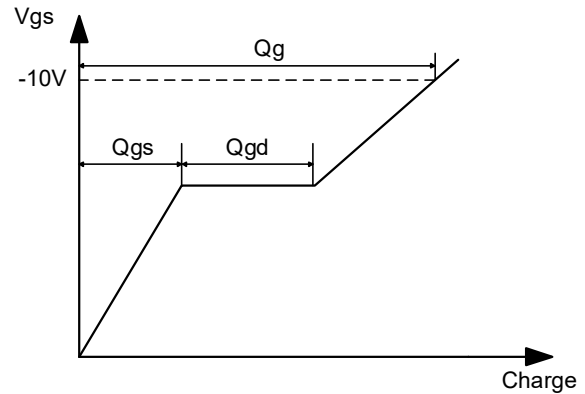
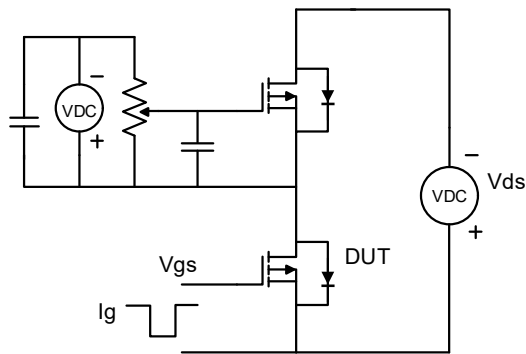
Transient Thermal Response (Junction-to-Case)



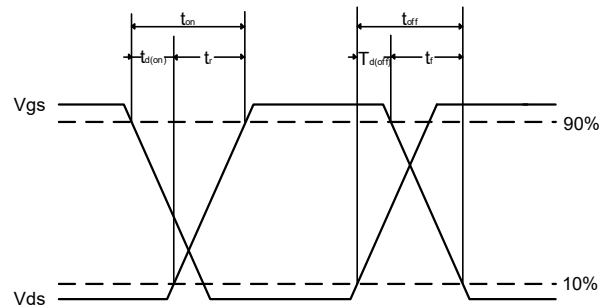
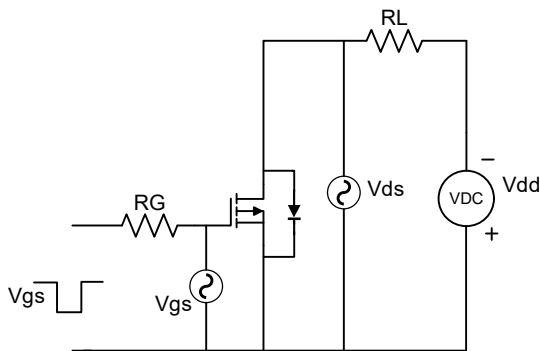
Transient Thermal Response (Junction-to-Ambient)



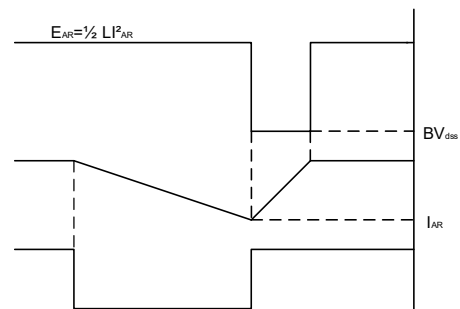
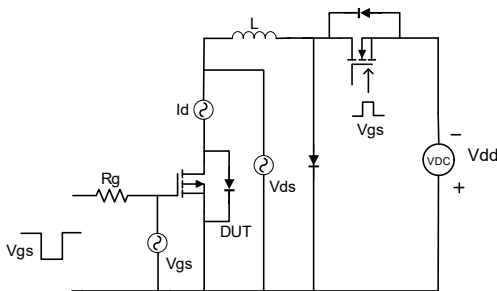
### Gate Charge Test Circuit & Waveform



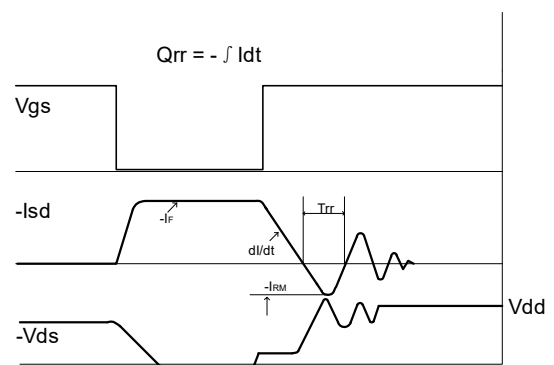
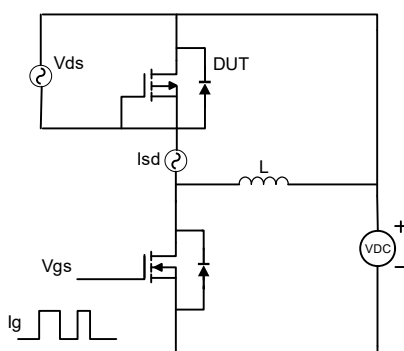
### Resistive Switching Test Circuit & Waveform



### Unclamped Inductive Switching(UIS) Test Circuit & Waveform

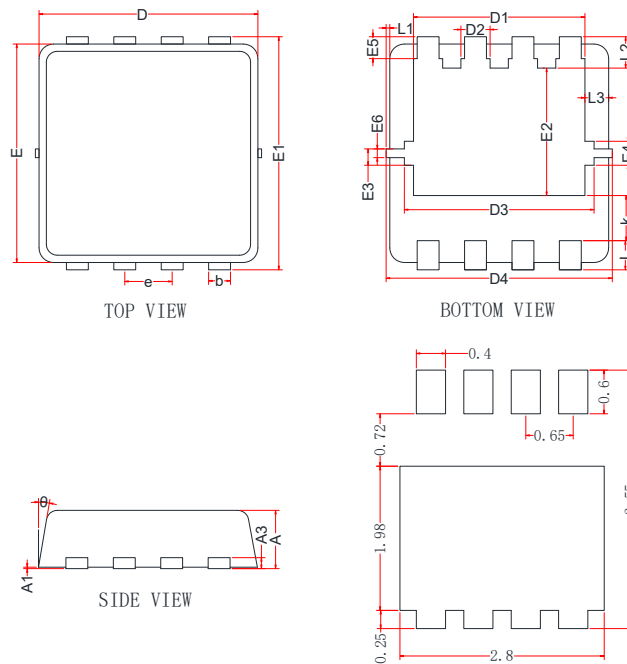


### Diode Recovery Test Circuit & Waveform



PACKAGE OUTLINE DIMENSIONS

PDFN3x3-8L



RECOMMENDED LAND PATTERN(Unit:mm)

Symbol	Dimensions in Millimeters		
	Min.	Typ.	Max.
A	0.70	0.80	0.90
A1	0.00	0.02	0.05
A3	0.10	0.15	0.25
b	0.24	0.30	0.35
D	2.90	3.00	3.10
D1	2.25	2.35	2.45
D2	0.30	0.40	0.50
D3	2.50	2.60	2.70
D4	3.00	3.10	3.20
E	2.90	3.00	3.10
E1	3.10	3.20	3.30
E2	1.65	1.75	1.85
E3	0.48	0.58	0.68
E4	0.23	0.33	0.43
E5	0.20	0.30	0.40
E6	0.07	0.12	0.18
e	0.60	0.65	0.70
K	0.52	0.62	0.72



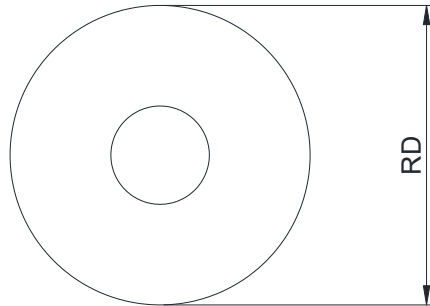


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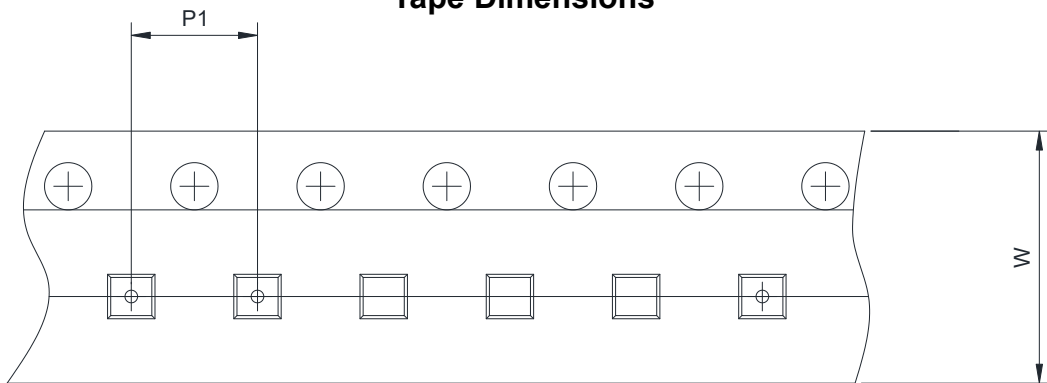
L	0.30	0.40	0.50
L1	0.00	0.05	0.10
L2	0.33	0.43	0.53
L3	0.27	0.37	0.48
θ	0°	10°	12°

**TAPE AND REEL INFORMATION**

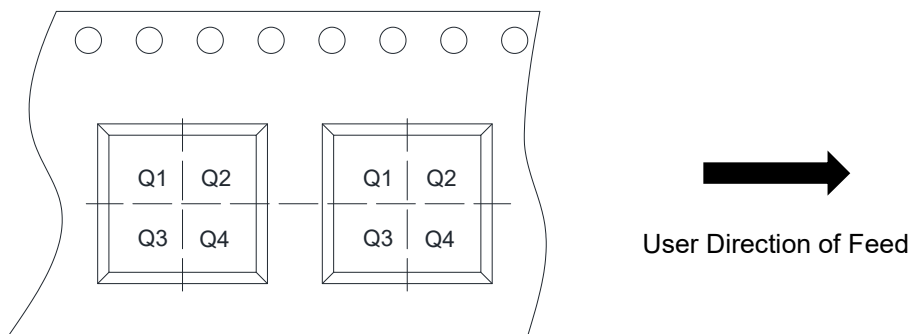
**Reel Dimensions**



**Tape Dimensions**



**Quadrant Assignments For PIN1 Orientation In Tape**



RD	Reel Dimension	<input type="checkbox"/> 7inch	<input checked="" type="checkbox"/> 13inch
W	Overall width of the carrier tape	<input type="checkbox"/> 8mm	<input checked="" type="checkbox"/> 12mm <input type="checkbox"/> 16mm
P1	Pitch between successive cavity centers	<input type="checkbox"/> 2mm	<input type="checkbox"/> 4mm <input checked="" type="checkbox"/> 8mm
Pin1	Pin1 Quadrant	<input checked="" type="checkbox"/> Q1	<input type="checkbox"/> Q2 <input type="checkbox"/> Q3 <input type="checkbox"/> Q4